Notice of References Cited Application/Control No. 10/598,969 Examiner SI LEE Applicant(s)/Patent Under Reexamination SUTTON ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,013,891	03-2006	Richardson et al.	128/201.15
*	В	US-4,945,907	08-1990	Tayebi, Amad	128/206.12
*	O	US-7,261,104	08-2007	Kiefer et al.	128/201.17
*	D	US-7,089,931	08-2006	Bee, Christopher Rodney	128/201.28
*	Е	US-5,323,774	06-1994	Fehlauer, Kai-Uwe	128/206.12
*	F	US-5,372,130	12-1994	Stern et al.	128/205.25
	G	US-			
	Ι	US-			
	_	US-			
	7	US-			
	K	US-	1		
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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